

<b>Notice of References Cited</b>	Application/Control No. 10/595,226	Applicant(s)/Patent Under Reexamination IKEDA ET AL.	
	Examiner LIN B. OLSEN	Art Unit 3661	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,570,609	11-1996	Nihei et al.	74/490.05
	B	US-			
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	EP 1085389 A1	03-2001	European Patent	TERADA et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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